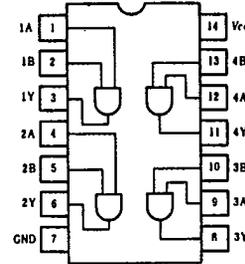


HD74ALS09

● Quadruple 2-Input Positive AND Gates
(with open collector outputs)

T-43-15

PIN ARRANGEMENT



(Top View)

ELECTRICAL CHARACTERISTICS (Ta = -20 ~ +75°C)

Item	Symbol	Test Conditions	min	typ*	max	Unit
Input voltage	V_{IH}		2.0	—	—	V
	V_{IL}		—	—	0.8	V
Output voltage	V_{OL}	$V_{CC}=4.5V, V_{IL}=0.8V, I_{OL}=4mA$	—	—	0.4	V
		$V_{CC}=4.75V, V_{IL}=0.8V, I_{OL}=8mA$	—	—	0.5	
Output current	I_{OH}	$V_{CC}=4.5V, V_{IL}=2V, V_{OH}=5.5V$	—	—	100	μA
Input current	I_{IH}	$V_{CC}=5.5V, V_I=2.7V$	—	—	20	μA
	I_I	$V_{CC}=5.5V, V_I=7V$	—	—	0.1	mA
	I_{IL}	$V_{CC}=5.5V, V_I=0.4V$	—	—	-0.2	mA
Supply current	I_{CCH}	$V_{CC}=5.5V, V_I=4.5V$	—	1.35	2.40	mA
	I_{CCL}	$V_{CC}=5.5V, V_I=0V$	—	2.2	4.0	mA
Input clamp voltage	V_{IK}	$V_{CC}=4.5V, I_{IN}=-18mA$	—	—	-1.5	V

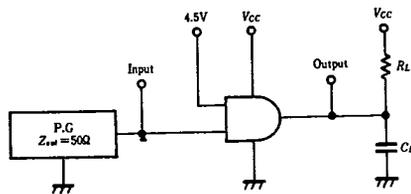
* $V_{CC}=5V, T_a=25^\circ C$

SWITCHING CHARACTERISTICS

Item	Symbol	Test Conditions	min	typ	max	Unit
Propagation delay time	t_{PLH}	$V_{CC}=5V, T_a=25^\circ C, R_L=2k\Omega, C_L=15pF$	—	20	—	ns
	t_{PHL}		—	10	—	
	t_{PLH}	$V_{CC}=5 \pm 0.5V, T_a=-20 \sim +75^\circ C, R_L=2k\Omega, C_L=50pF$	20	—	54	
	t_{PHL}		7	—	18	

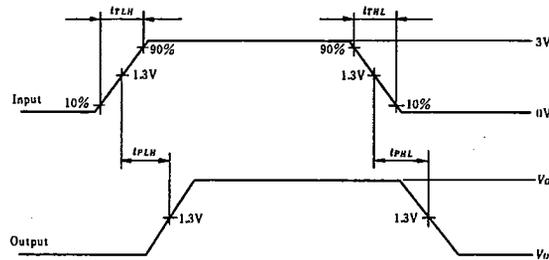
TESTING METHOD

Test Circuit



Note: C_L includes probe and jig capacitance.

Waveform



Input pulse: $t_{TLH} \leq 6ns, t_{THL} \leq 6ns, PRR = 1MHz, \text{duty cycle } 50\%$